

SPECIFICATIONS ($T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)

Parameter	Symbol	Test Conditions		Typ ^a	Limits						Unit
					2N5114		2N5115		2N5116		
					Min	Max	Min	Max	Min	Max	
Static											
Gate-Source Breakdown Voltage	V _{(BR)GSS}	I _G = 1 μA , V _{DS} = 0 V		45	30		30		30		V
Gate-Source Cutoff Voltage	V _{GS(off)}	V _{DS} = −15 V, I _D = −1 nA			5	10	3	6	1	4	
Saturation Drain Current ^b	I _{DSS}	V _{GS} = 0 V	V _{DS} = −18 V		−30	−90					mA
			V _{DS} = −15 V			−15	−60	−5	−25		
Gate Reverse Current	I _{GSS}	V _{GS} = 20 V, V _{DS} = 0 V		5		500		500		500	pA
		T _A = 150°C		0.01		1		1		1	μA
Gate Operating Current ^c	I _G	V _{DG} = −15 V, I _D = −1 mA		−5							
Drain Cutoff Current	I _{D(off)}	V _{DS} = −15 V	V _{GS} = 12 V	−10		−500					pA
			V _{GS} = 7 V	−10			−500				
			V _{GS} = 5 V	−10					−500		
		V _{DS} = −15 V T _A = 150°C	V _{GS} = 12 V	−0.02		−1					μA
			V _{GS} = 7 V	−0.02			−1				
			V _{GS} = 5 V	−0.02					−1		
Drain-Source On-Voltage	V _{DS(on)}	V _{GS} = 0 V	I _D = −15 mA	−1.0		−1.3					V
			I _D = −7 mA	−0.7			−0.8				
			I _D = −3 mA	−0.5					−0.6		
Drain-Source On-Resistance	r _{DS(on)}	V _{GS} = 0 V, I _D = −1 mA				75		100		150	Ω
Gate-Source Forward Voltage	V _{GS(F)}	I _G = −1 mA , V _{DS} = 0 V		−0.7		−1		−1		−1	V
Dynamic											
Drain-Source On-Resistance	r _{ds(on)}	V _{GS} = 0 V, I _D = 0 mA , f = 1 kHz				75		100		175	Ω
Common-Source Input Capacitance	C _{iss}	V _{DS} = −15 V, V _{GS} = 0 V f = 1 MHz		20		25		25		27	pF
Common-Source Reverse Transfer Capacitance	C _{rss}	V _{DS} = 0 V f = 1 MHz	V _{GS} = 12 V	5		7					
			V _{GS} = 7 V	6			7				
			V _{GS} = 5 V	6					7		
Switching											
Turn-On Time	t _{d(on)}	See Switching Circuit				6		10		25	ns
	t _r					10		20		35	
Turn-Off Time	t _{d(off)}					6		8		20	
	t _f					15		30		60	

Notes

- a. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
b. Pulse test: $PW \leq 300\ \mu\text{s}$ duty cycle $\leq 3\%$.
c. This parameter not registered with JEDEC.

PSCIA



SWITCHING TIME TEST CIRCUIT			
	2N5114	2N5115	2N5116
V_{DD}	-10 V	-6 V	-6 V
V_{GG}	20 V	12 V	8 V
R_L^*	430 Ω	910 Ω	2000 Ω
R_G^*	100 Ω	220 Ω	390 Ω
$I_{D(on)}$	-15 mA	-7 mA	-3 mA
$V_{GS(H)}$	0 V	0 V	0 V
$V_{GS(L)}$	-11 V	-7 V	-5 V

*Non-inductive

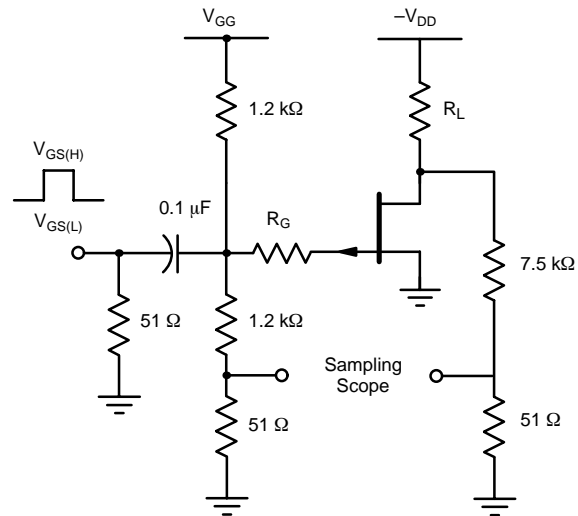
INPUT PULSE

Rise Time < 1 ns
Fall Time < 1 ns
Pulse Width 100 ns
PRF 1 MHz

SAMPLING SCOPE

Rise Time 0.4 ns
Input Resistance 10 M Ω
Input Capacitance 1.5 pF

See Typical Characteristics curves for changes.





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